## Acetonitrile BAKER ANALYZED® HPLC Ultra Gradient Solvent

For use in Liquid Chromatography (HPLC & UHPLC) & Spectrophotometry





Material No.: 9017-03 Batch No.: 0000152366 Manufactured Date: 2016/08/25

Retest Date: 2021/08/24

## Certificate of Analysis

| Test   | Specification | Result  |
|--|---------------|---------|
| lltraviolet Absorbance (1.00-cm cell vs. water) –<br>00-254 nm                                 | <= 0.005      | < 0.002 |
| ltraviolet Absorbance (1.00-cm cell vs. water) - 220<br>m                                      | <= 0.01       | < 0.01  |
| ltraviolet Absorbance (1.00-cm cell vs. water) – 200<br>m                                      | <= 0.05       | < 0.01  |
| lltraviolet Absorbance (1.00-cm cell vs. water) – UV<br>Cut-off, nm                            | <= 190        | 187     |
| Gradient Elution Test (a.u.) – 254 nm  | <= 0.0005     | 0.0002  |
| Gradient Elution Test (a.u.) – 210 nm  | <= 0.002      | 0.001   |
| Density (g/mL) at 25°C   | 0.775 - 0.780 | 0.776   |
| luorescence Trace Impurities, measured as Quinine<br>lase – at 450 nm Emission                 | <= 0.3 ppb    | 0.1     |
| luorescence Trace Impurities, measured as Quinine<br>lase – at Emission Maximum for Impurities | <= 1.0 ppb    | 0.2     |
| assay (CH3CN) (by GC)  | >= 99.9 %     | 100.0   |
| appearance   | Passes Test   | PT      |
| Color (APHA)   | <= 10         | 5       |
| luorescence Trace Impurities, measured as Quinine<br>lase – Fluorescence detection (PAH)       | <= 0.5 ppb    | 0.2     |
| lesidue after Evaporation  | <= 1.0 ppm    | < 0.1   |
| Titrable Acid (µeq/g)  | <= 0.8        | 0.1     |
| itrable Base (μeq/g)   | <= 0.6        | < 0.1   |
| Vater (by KF, coulometric)   | <= 100 ppm    | 24      |
| Carbonyl Compounds (as Acetone)  | <= 25 ppb     | 20      |

For Laboratory, Research or Manufacturing Use

Material No.: 9017-03 Batch No.: 0000152366

Filtered through a 0.2 micron filter.

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
Paris, KY 9001:2008
Mexico City, Mexico 9001:2008
Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
Gliwice, Poland 9001:2008, 13485:2012
Selangor, Malaysia 9001:2008
Dehradun, India, 9001:2008, 14001:2004, 13485:2003
Mumbai, India, 9001:2008

Panoli, India 9001:2008

Jamie Ethier
Vice President Global Quality